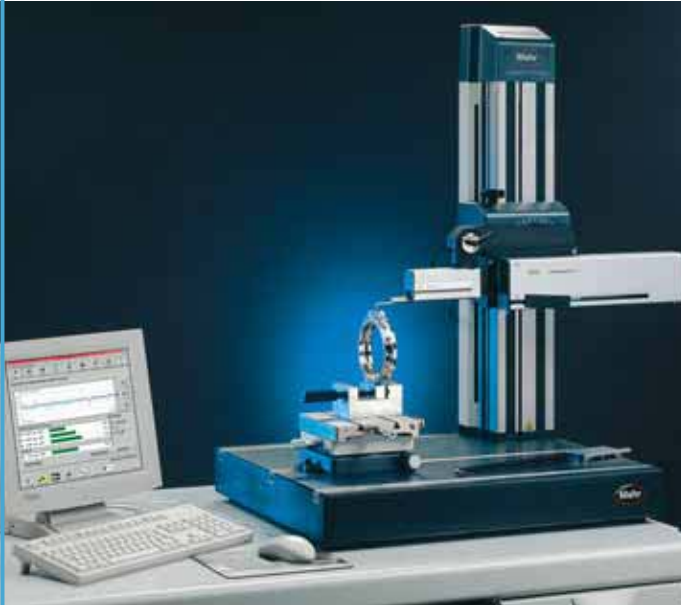


MarSurf XCR 20

The new generation of combined roughness and contour measurement systems

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Description

MarSurf XCR 20 is ideal for combining contour and roughness depth evaluation.

Marsurf XC 20 + MarSurf XR 20 = MarSurf XCR 20

This system includes absolutely everything you need, saving both time and space. There are separate user interfaces for the roughness and contour software. **MarSurf XCR 20** is Mahr's top surface measurement system and enables even semi-automated operating sequences to be performed.

Versions

- Combi-measuring station with one measuring stand and two drive units (**PCV 200** and **MarSurf GD 25**)
- Combi-measuring station with quick-change mounts (**PGK 120, PCV 200**)
- **MarSurf UD 120 / LD 120** enables high-precision contour and roughness evaluation on components



WebCode 3152

Features

- Saves space because both drive units (**MarSurf PCV 200** contour drive unit and **GD 25** roughness drive unit) can be adapted using the corresponding combi-mount on the **ST 500** or **ST 750** measuring stand
- Roughness and contour evaluations possible from a single measurement
- High-precision contour and roughness evaluation with the **MarSurf LD 120** measuring system on components requiring a large stroke and very high resolution
- Option of rapidly switching between roughness and contour measurements thanks to straightforward changeover within the software platform and changing of mechanical components such as drive unit and probe.

